

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/815,446	BODE ET AL.
	Examiner Dwin M. Craig	Art Unit 2123

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (Please see the search notes for the search terms)	7/21/2005	<i>JM</i>
IEEE (Field Mean Error, wafer error)	7/21/2005	<i>DNL</i>
PALM (Inventor Name Search)	7/22/2005	<i>DNL</i>

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner